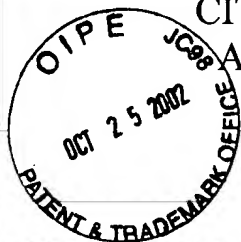


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# INFORMATION DISCLOSURE CITATION IN AN APPLICATION



(PTO-1449)

 ATTY. DOCKET NO.  
**43889-996**

 SERIAL NO.  
**09/712,247**

 APPLICANT  
**Keiichi KUSUMOTO, et al.**

 FILING DATE  
**November 15, 2000**

 GROUP  
**2634**

## U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE

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## FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
DL	10-190465	7/21/1998	Japan (w/ English Abstract-corresp. to US 6,025,794)				
	9-190693	7/22/1997	Japan (w/ English Abstract)				
	4-159690	6/2/1992	Japan (w/ English Abstract and Partial English Translation)				
	4-150615	5/25/1992	Japan (w/ English Abstract)				
	11-195966	7/21/1999	Japan (w/ English Abstract)				
	10-134581	5/22/1998	Japan (w/ English Abstract)				
DL	9-130250	5/16/1997	Japan (w/ English Abstract)				

## OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)


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<b>INFORMATION DISCLOSURE CITATION IN AN APPLICATION</b>  <b>(PTO-1449)</b>		<b>ATTY. DOCKET NO.</b> <b>43889-996</b>		<b>SERIAL NO.</b> <b>09/712,247</b>			
		<b>APPLICANT</b> <b>Keiichi KUSUMOTO, et al.</b>					
		<b>FILING DATE</b> <b>November 15, 2000</b>		<b>GROUP</b> <b>2634</b>			
<b>U.S. PATENT DOCUMENTS</b>							
EXAMINER'S INITIALS	CITE NO.	Document Number <small>Number-Kind Code<sup>2</sup> (if known)</small>	Publication Date <small>MM-DD-YYYY</small>	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear		
		US			<div style="font-size: 2em; font-weight: bold;">RECEIVED</div> <div style="font-size: 1.2em; font-weight: bold;">AUG 26 2003</div> <div style="font-size: 1.2em; font-weight: bold;">Technology Center 2600</div>		
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<b>FOREIGN PATENT DOCUMENTS</b>							
EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document <small>Country Codes - Number 4 - Kind Codes (if known)</small>	Publication Date <small>MM-DD-YYYY</small>	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation	
						Yes	No
DL		JP 3-64118	03/19/1991	FUJITSU LTD.		JAPAN (w/English Abstract)	
<b>OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)</b>							
EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.					
EXAMINER		DATE CONSIDERED					
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EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code <sup>2</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
DL		US 5,654,653	08/05/1997	Coyle et al.	
DL		US 5,661,417	08/26/1997	Kondoh	
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## FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Code <sup>3</sup> -Number 4 -Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation	
						Yes	No

## OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.

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David Lugo

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